

**Search Notes**

Application/Control No.

10/522,202

Examiner

Shih-Chao Chen

Applicant(s)/Patent under  
Reexamination

MARTIN ET AL.

Art Unit

2821

**SEARCHED**

Class	Subclass	Date	Examiner
343	742, 867, 895	7/15/2007	CHEN
340	572,1	7/15/2007	CHEN
235	492	7/15/2007	CHEN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (See attached printout).	7/15/2007	CHEN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner